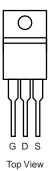
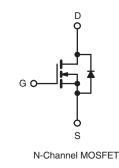


N-Channel 500-V (D-S) Super Junction MOSFET

PRODUCT SUMMARY					
V_{DS} (V) at T_{J} max.	500				
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V 0.115				
Q _g (Max.) (nC)	86				
Q _{gs} (nC)	14				
Q _{gd} (nC)	25				
Configuration	Single				

TO-220AB





FEATURES

- Low figure-of-merit (FOM): Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Low gate charge (Q_g)
- Avalanche energy rated (UIS)

APPLICATONS

- Hard switched topologies
- Power factor correction power supplies (PFC)
- Switch mode power supplies (SMPS)
- Computing
 - PC silver box / ATX power supplies
- Lighting
- Two stage LED lighting

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V _{GS}	± 30	v	
Continuous Drain Current (T, = 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	l _D	30		
Continuous Drain Current $(1_j = 150^{\circ} C)$	V _{GS} at 10 V	T _C = 100 °C		18	А	
Pulsed Drain Current ^a		I _{DM}	105			
Linear Derating Factor			0.2	W/°C		
Single Pulse Avalanche Energy ^b		E _{AS}	273	mJ		
Maximum Power Dissipation			PD	280	W	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C		
Drain-Source Voltage Slope $V_{DS} = 0 V to 80 \% V_{DS}$		dV/dt	65	V/ns		
Reverse Diode dV/dt ^d			25	v/ns		
Soldering Recommendations (Peak Temperature) c for 10 s			300	°C		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.4 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C.

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.5	0/11

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		•		•	•	•	•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Onto Doumas Laskage			V _{GS} = ± 20 V	-	-	± 100	nA
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 1	μA
Zava Cata Vialtaga Dirain Current		V _{DS} =	$V_{DS} = 500 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	1	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	25	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 12 A	-	0.115	-	Ω
Forward Transconductance	g fs	V _{DS}	= 30 V, I _D = 12 A	-	6.6	-	S
Dynamic		•		•	•	•	
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	1980	-	
Output Capacitance	C _{oss}		V _{DS} = 100 V,	-	105	-	
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		-	8	-	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	105	-	pF
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	$v_{\rm DS} = 0.0$	/ to 400 V, $V_{GS} = 0 V$	-	285	-	
Total Gate Charge	Qq			-	57	86	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	I _D = 12 A, V _{DS} = 400 V	-	14	-	nC
Gate-Drain Charge	Q _{qd}			-	25	-	
Turn-On Delay Time	t _{d(on)}			-	19	38	
Rise Time	t _r	$\begin{array}{c c} & - & 19 \\ \hline V_{DD} = 400 \text{ V}, \text{ I}_{D} = 12 \text{ A} & - & 36 \\ \hline R_{g} = 9.1 \Omega, \text{ V}_{GS} = 10 \text{ V} & - & 57 \end{array}$		-	36	72	1
Turn-Off Delay Time	t _{d(off)}			86	ns		
Fall Time	t _f			-	29	58	1
Gate Input Resistance	Rg	f = 1	f = 1 MHz, open drain		0.56	-	Ω
Drain-Source Body Diode Characteristic	s	•		•	•	•	•
Continuous Source-Drain Diode Current	IS	MOSFET sym showing the		-	-	12	
Pulsed Diode Forward Current	I _{SM}	integral reverse p - n junction diode		-	-	50	A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 16.5 A, V _{GS} = 0 V		-	-	1.2	V
Reverse Recovery Time	t _{rr}	-		-	338	-	ns
Reverse Recovery Charge	Q _{rr}	$T_{J} = 25 \text{ °C, } I_{F} = I_{S}, \qquad - 5.3$		-	μC		
Reverse Recovery Current	I _{RRM}		$100 Pv \mu s, v_{\rm R} = 20 v$	-	29	-	A

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

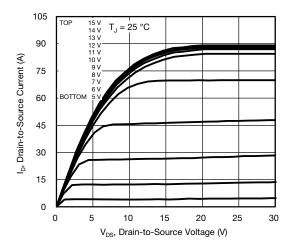


Fig. 1 - Typical Output Characteristics

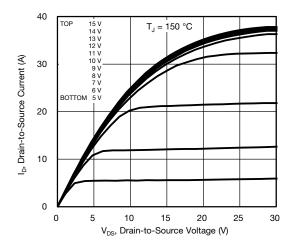


Fig. 2 - Typical Output Characteristics

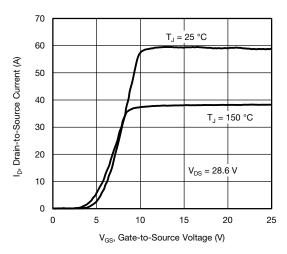


Fig. 3 - Typical Transfer Characteristics

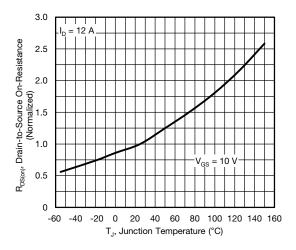


Fig. 4 - Normalized On-Resistance vs. Temperature

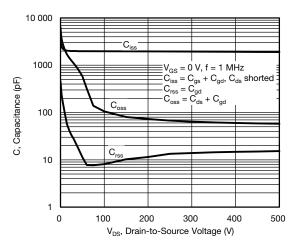


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

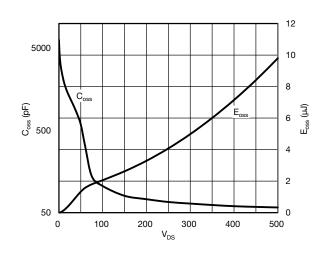


Fig. 6 - C_{OSS} and E_{OSS} vs. V_{DS}

VBM15R30S

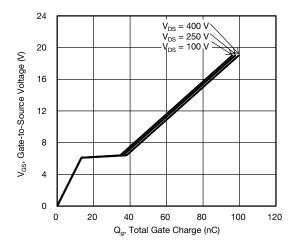


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

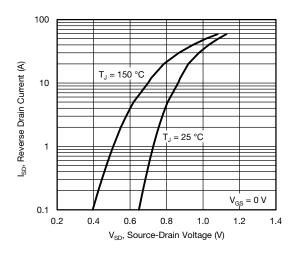


Fig. 8 - Typical Source-Drain Diode Forward Voltage

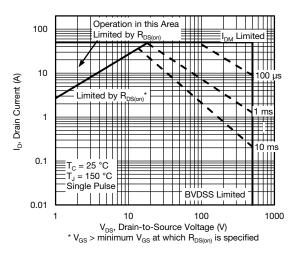
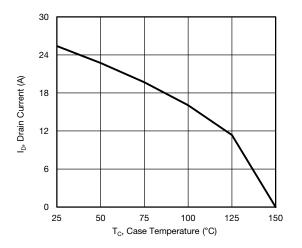


Fig. 9 - Maximum Safe Operating Area



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Fig. 10 - Maximum Drain Current vs. Case Temperature

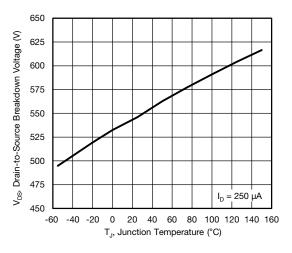


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature

VBM15R30S

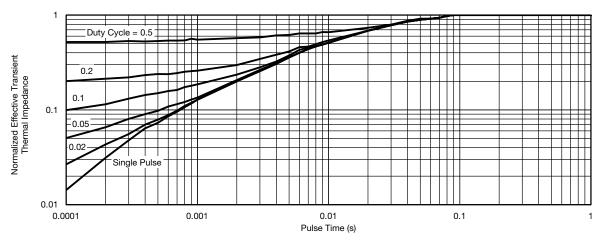


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

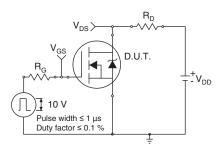


Fig. 13 - Switching Time Test Circuit

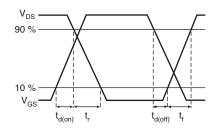


Fig. 14 - Switching Time Waveforms

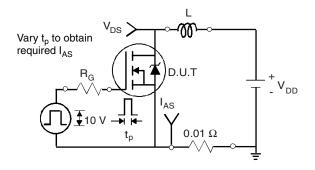


Fig. 15 - Unclamped Inductive Test Circuit

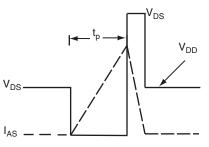


Fig. 16 - Unclamped Inductive Waveforms

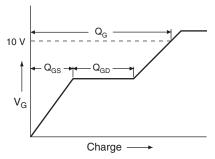


Fig. 17 - Basic Gate Charge Waveform

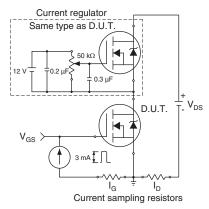


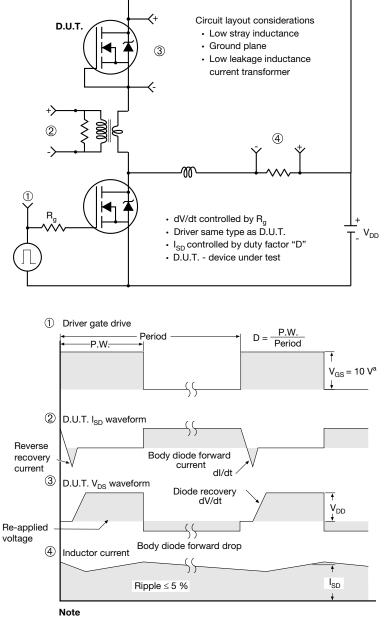
Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit

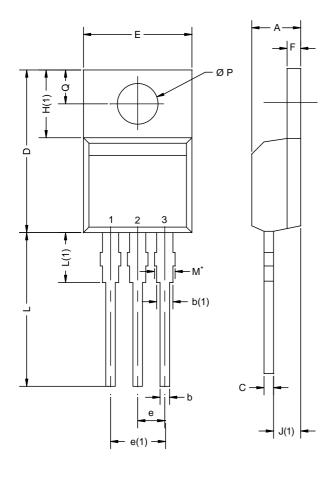


a. V_{GS} = 5 V for logic level devices

Fig. 19 - For N-Channel



TO-220AB



MIL		IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØР	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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